

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BAE ET AL.	
		Examiner Tan Ho	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,333,722 B1	12-2001	Kitano, Shinichiro	343/895
*	B	US-6,369,777 B1	04-2002	Ohara et al.	343/895
*	C	US-6,421,015 B1	07-2002	Chen, I-Fong	343/700MS
*	D	US-6,448,934 B1	09-2002	Lee et al.	343/702
*	E	US-6,501,438 B2	12-2002	Nevermann et al.	343/895
*	F	US-6,583,769 B2	06-2003	Shiroki et al.	343/895
*	G	US-6,680,713 B2	01-2004	Yokoshima et al.	343/895
*	H	US-6,163,307 A	12-2000	Kim et al.	343/895
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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